Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L7	11016	((358/3.28) or (382/100,232,240) or (380/51,54,210,252,287) or (386/94) or (283/72,74,75,76,77, 78,79,80,81,83,85,93,113,901,902) or (13/176,179)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:13
L8	1860	7 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:50
L9	137	8 and halfton\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:57
L10	48	9 and generator\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:57
L11	47	10 and embed\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:02
L12	11	11 and (binary near4 pattern)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:09
L13	75	image adj generator\$4 and ((embed\$4) near4 (machine or devic\$4 or system or apparatus))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:50
L14	16	13 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:49

L15	2	14 and (binary near4 pattern)	US-PGPUB; USPAT; USOCR; EPO; JPO;	OR	OFF	2005/01/20 16:31
			DERWENT; IBM_TDB			
L16	51	("2X2" or "2 by 2" or "2 times 2") same binary	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:26
L17	1	16 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:30
L19	10	7 and 16	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:13
L20	136	("2X2" or "2 by 2" or "2 times 2") same matrix	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:29
L21	1	20 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:27
L22	221	("2X2" or "2 by 2" or "2 times 2") same (window\$3 or martric\$2 or matrix\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:30
L23	4	22 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:30

L24	0	22 and (binary near4 pattern)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:42
L25	1	7 and 22	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:31
L26	38	22 and (binary)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:42
L27	260	(358/3.2,3.28).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:50
L28	99	27 and (watermark\$4 or steganograph\$4 or water-mark\$4 or invisibl\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:50
L29	40	28 and ((embed\$4) near4 (machine or devic\$4 or system or apparatus))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:50
L30	15	29 and generator\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:56
L31	1025	watermark\$3 near4 ((embed\$4) near4 (device or system or machine or apparatus))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:57

L32	198	31 and generator\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:57
L33	45	31 and halfton\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/01/20 16:57

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O- By Author O- Basic O- Advanced O- CrossRef	1 Image processing for halftones Ping Wah Wong; Memon, N.D.; Signal Processing Magazine, IEEE , Volume: 20 , Issue: 4 , July 2003 Pages:59 - 70
Member Services Join IEEE Establish IEEE Web Account Access the IEEE Member Digital Library	[Abstract] [PDF Full-Text (8824 KB)] IEEE JNL 2 A watermark sharing scheme to halftone images with genetic algori Myodo, E.; Tanaka, K.; Signal Processing and Information Technology, 2003. ISSPIT 2003. Proceeding the 3rd IEEE International Symposium on , 14-17 Dec. 2003 Pages:194 - 198
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5 Data hiding in halftone images by conjugate error diffusion

Ming Sun Fu; Au, O.C.;

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